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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Application Serial No	0/053,201
Confirmation No	
Filing Date January	15, 2002
Inventor	erg, et al.
Assignee Honeywell Interna	tional Inc.
Group Art Unit	2818
Examiner	. P. Dang
Attorney's Docket No	93-CON1
Customer No	021567
Title: Tantalum Sputtering Target and Method of Manufacture	

INFORMATION DISCLOSURE STATEMENT PURSUANT TO 37 C.F.R. §§ 1.56, 1.97 AND 1.98

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed together with the filing of the Request for Continued Examination (RCE) Application and before receipt of the first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of these references is respectfully requested.

Respectfully submitted,

Dated: 29 Aug 2003 By

James (Lake

Reg. No. 44,854

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		LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)			APPLICANT Harry Rosenberg et al						
					FILING DATE January 15, 2002		GROUP 2818				
U.S. PATENT DOCUMENTS											
*Examiner Initial		Document Number				Name		Class	Subclass	Filing Date If Appropriate	
	AA	5,244,556		09/1993	Inoue		 -				
	AB	3,984,208		10/1976	Moulin et al						
	AC	5,972,288		10/1999	Jeong et al						
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		Document Number		Date	Country			Class	Subclass	Translation	
										Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)											
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EXAMINER					DATE	CONSIDER	ED				
*EXAMINER: considered.	Initial if Include c	referen	ce considered, wheth	er or not citation to	on is in conformance to applicant.	e with MPE	P 609; Draw line thr	ough citation	n if not in co	onformance a	nd not